### SCOPE :

This specification applies to the Pb Free high current type SMD inductors for MNR-6045-SERIES

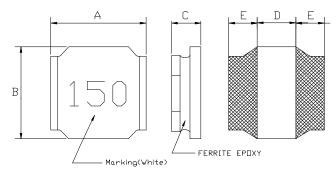
#### **PRODUCT INDENTIFICATION**

#### <u>MNR - 6045 - 150 M</u>

1 2	3	4
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- ① Product Code
- ② Dimensions Code
- ③ Inductance Code
- Tolerance Code

### (1) SHAPES AND DIMENSIONS



A: 6.0±0.3	mm
B: 6.0±0.3	mm
C: 4.5 Max.	mm
D: 3.10Typ.	mm
Е: 1.45Тур.	mm

### (2) ELECTRICAL SPECIFICATIONS SEE TABLE 1

**TEST INSTRUMENTS** 

L : HP 4284A PRECISION LCR METER (or equivalent)

SRF : HP 4291B IMPEDANCE ANALYZER (or equivalent)

RDC : CHROMA MODEL 16502 MILLIOHMMETER (or equivalent)

### (3) CHARACTERISTICS

- (3)-1 Ambient temperature ...... +60  $^\circ\!\! \mathbb C$  Max.
- (3)-2 Operate temperature range ......  $-40^\circ\!\!C\!\sim\!+125^\circ\!\!C$ 
  - (Including self temp. rise)
- (3)-3 Storage temperature range ......  $-40^\circ C \sim +125^\circ C$



#### TABLE 1

MAGLAYERS	Inductance	Percent	L Test	SRF(MHz)	Resistance	Rated D	C Current	Marking
PT/NO.	L(µH)	Tolerance	Frequency	Тур.	RDC(Ω)±30%	IDC1(A)	IDC2(A)	warking
MNR-6045-1R0	1.0	N	100KHz/0.25V	110	14m	8.50	4.20	1R0
MNR-6045-2R2	2.2	N	100KHz/0.25V	60	21m	6.00	3.50	2R2
MNR-6045-2R3	2.3	N	100KHz/0.25V	60	21m	6.00	3.50	2R3
MNR-6045-3R0	3.0	M,N	100KHz/0.25V	45	24m	5.00	3.20	3R0
MNR-6045-3R3	3.3	M,N	100KHz/0.25V	45	25m	4.80	3.10	3R3
MNR-6045-4R5	4.5	M,N	100KHz/0.25V	25	31m	4.00	3.00	4R5
MNR-6045-4R7	4.7	M,N	100KHz/0.25V	25	31m	4.00	3.00	4R7
MNR-6045-6R3	6.3	M,N	100KHz/0.25V	15	38m	3.80	2.80	6R3
MNR-6045-100	10	M,N	100KHz/0.25V	12	47m	3.00	2.50	100
MNR-6045-150	15	M,N	100KHz/0.25V	10	77m	2.30	1.90	150
MNR-6045-220	22	M,N	100KHz/0.25V	7	0.115	1.90	1.50	220
MNR-6045-470	47	M,N	100KHz/0.25V	5	0.220	1.30	1.10	470
MNR-6045-101	100	M,N	100KHz/0.25V	3	0.500	0.80	0.70	101

% □ specify the inductance tolerance,M(±20%),N(±30%)

% IDC1 : Based on inductance change ( $\triangle$ L/Lo : drop 30% Max.) @ ambient temp. 25°C

IDC2 : Based on temperature rise ( $\triangle T$  : 40°C Typ.)

Rated DC Current : The less value whith is IDC1 or IDC2.



# (4) RELIABILITY TEST METHOD

### MECHANICAL

TEST ITEM	SPECIFICATION	TEST DETAILS
Substrate bending	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board
		in figure 1 and a load applied unitil the figure in the arrow
	There shall be	direction is made approximately 3mm.(keep time 30 seconds)
	no mechanical	PCB dimension shall the page 7/9
	damage or elec-	F(Pressurization)
	trical damege.	л
		R5 45±2 45±2 10 20 R340
		PRESSURE ROD figure-1
Vibration	∆L/Lo≦±5%	The sample shall be soldered onto the printed circuit board
		and when a vibration having an amplitude of 1.52mm
	There shall be	and a frequency of from 10 to 55Hz/1 minute repeated should
	no mechanical	be applied to the 3 directions (X,Y,Z) for 2 hours each.
	damage.	(A total of 6 hours)
Solderability	New solder	Flux (rosin, isopropyl alcohol{JIS-K-1522}) shall be coated
concorability	More than 90%	over the whole of the sample before hard, the sample shall
		then be preheated for about 2 minutes in a temperature of
		130 $\sim$ 150 $^\circ\!\mathbb{C}$ and after it has been immersed to a depth 0.5mm
		below for $3\pm0.2$ seconds fully in molten solder M705 with
		a temperature of 245±5℃.
		More than 90% of the electrode sections shall be couered
		with new solder smoothly when the sample is taken out of
		the solder bath.



#### MECHANICAL

TEST ITEM	SPECIFICATION				
TEST ITEMResistance toThere shall beSoldering heatno damage or(reflow soldering)problems.	SPECIFICATION Temperature profile of reflow soldering 300 soldering (Peak temperature 20013C 10 sec 250 200 Pre-heating 150 Pre-heating 150 Slow cooling (Stored at room temperature) 50 2 min or mare				
		The specimen shall be passed through the reflow oven with the condition shown in the above profile for 1 time. The specimen shall be stored at standard atmospheric conditions for 1 hour, after which the measurement shall be made.			

#### **ELECTRICAL**

TEST ITEM	SPECIFICATION	TEST DETAILS
Insulation	There shall be	DC 100V voltage shall be applied across this sample of top
resistance	no other	surface and the terminal.
	damage or	The insulation resistance shall be more than 1 × 10 <sup>8</sup> $\Omega$ .
	problems.	
Dielectric	There shall be	AC 100V voltage shall be applied for 1 minute acrosset the top
withstand	no other	surface and the terminal of this sample
voltage	damage or	
	problems.	
Temperature	∆L/L20℃ ≦±10%	The test shall be performed after the sample has stabilized in
characteristics	<b>0∼2000 ppm/</b> ℃	an ambient temperature of -20 to +85 $^\circ\!\mathrm{C}$ ,and the value
		calculated based on the value applicable in a normal
		temperature and narmal humidity shall be $ riangle L/L20^{\circ}C \leq \pm 10\%$ .



## **ENVIROMENT CHARACTERISTICS**

TEST ITEM		SPECIFICATION					
High temperature	∆L/Lo≦±5%	The sample shall be left for 96±4 hours in an atmospere with					
storage		a tempera	a temperature of 85±2 $^\circ\!\mathrm{C}$ and a normal humidity.				
	There shall be	Upon cor	Upon completion of the measurement shall be made after the				
	no mechanical	sample h	sample has been left in a normal temperature and normal				
	damage.	humidity	humidity for 1 hour.				
Low temperature	∆L/Lo≦±5%	The samp	ole sł	hall be left for 96±4 hours	s in an atmosphere with		
storage		a tempera	ature	of -25±3℃.			
	There shall be	Upon cor	nplet	ion of the test, the meas	urement shall be made		
	no mechanical	after the	samp	ble has been left in a nor	mal temperature and		
	damage.	normal h	umid	ity for 1 hour.			
Change of	∆L/Lo≦±5%	The samp	ole sł	nall be subject to 5 contin	nuos cycles, such as shown		
temperature		in the tab	le 2 l	below and then it shall be	e subjected to standard		
	There shall be	atmosphe	eric c	conditions for 1 hour, after	er which measurement		
	no other dama-	shall be r	nade				
	ge of problems						
				table 2			
				Temperature	Duration		
			1	− <b>25±3°</b> C	30 min.		
				(Themostat No.1)			
			2	Standard	No.1→No.2		
				atmospheric			
			3	<b>85±2℃</b>	30 min.		
		_		(Themostat No.2)			
		4	Standard	No.2→No.1			
				atmospheric			
Moisture storage	∆L/Lo≦±5%	The sample shall be left for 96±4 hours in a temperature of					
_		$40\pm2^{\circ}$ and a humidity(RH) of 90~95%.					
	There shall be	Upon completion of the test, the measurement shall be made after the sample has been left in a normal temperature and					
	no mechanical						
	damage.	normal humidity more than 1 hour.					
Test conditions :	1	I					
The	sample shall be reflow	w soldered o	onto t	he printed circuit board	in every test.		

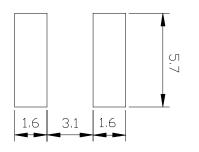


## (5) LAND DIMENSION (Ref.)

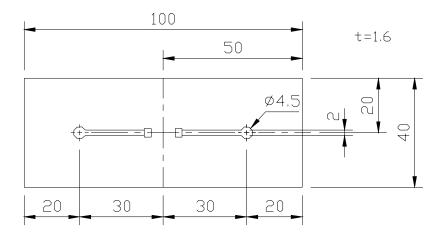
PCB: GLASS EPOXY t=1.6mm

#### (5)-1 LAND PATTERN DIMENSIONS

(STANDARD PATTERN) unit : mm

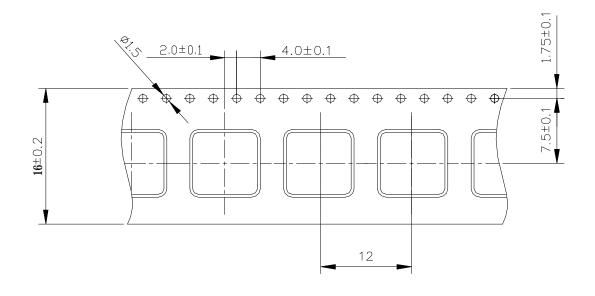


### (5)-2 SUBSTRATE BENDING TEST BENDING TEST BOARD

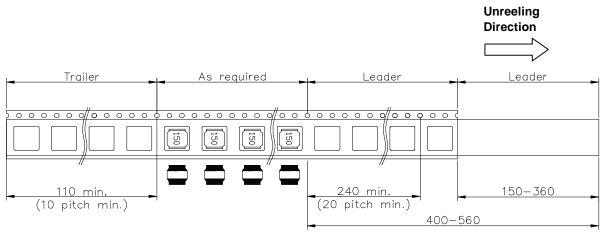




## (6) PACKAGING (6)-1 CARRIER TAPE DIMENSIONS (mm)

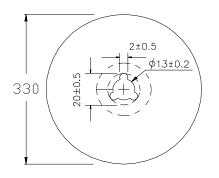


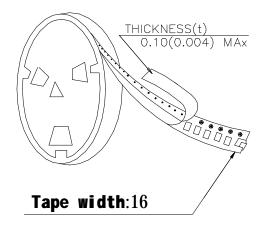
### (6)-2 TAPING DIMENSIONS (mm)





## (6)-3 REEL DIMENSIONS (mm)





## (6)-4 QUANTITY

1000pcs/Reel

The products are packaged so that no damage will be sustained.



MNR-6045-SERIES

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单击下面可查看定价,库存,交付和生命周期等信息

>>MAG. LAYERS